

# MOSFET – Dual, N-Channel, Shielded Gate, POWERTRENCH®

100 V, 1.2 A, 350 mΩ

## **FDC8602**

## **General Description**

This N-Channel MOSFET is produced using **onsemi**'s advanced POWERTRENCH process that incorporates Shielded Gate technology. This process has been optimized for R<sub>DS(on)</sub>, switching performance and ruggedness.

#### **Features**

- Shielded Gate MOSFET Technology
- Max  $R_{DS(on)} = 350 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 1.2 \text{ A}$
- Max  $R_{DS(on)} = 575 \text{ m}\Omega$  at  $V_{GS} = 6 \text{ V}$ ,  $I_D = 0.9 \text{ A}$
- High Performance Trench Technology for Extremely Low R<sub>DS(on)</sub>
- High Power and Current Handling Capability in a Widely Used Surface Mount Package
- Fast Switching Speed
- 100% UIL Tested
- This Device is Pb-Free, Halide Free and is RoHS Compliant

#### **Applications**

- Load Switch
- Synchronous Rectifier

#### MAXIMUM RATINGS (T<sub>A</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain to Source Voltage	100	V
$V_{GS}$	Gate to Source Voltage	±20	V
I <sub>D</sub>	Drain Current: Continuous (Note 1a) Pulsed	1.2 5	Α
E <sub>AS</sub>	Single Pulse Avalanche Energy (Note 3)	1.5	mJ
P <sub>D</sub>	Power Dissipation: (Note 1a) (Note 1b)	0.96 0.69	W
$T_J$ , $T_{STG}$	Operating and Storage Junction Temperature Range	–55 to +150	ô

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

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V <sub>DS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
100 V	350 mΩ @ 10 V	1.2 A
	575 mΩ @ 6 V	



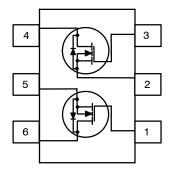
TSOT23 6-Lead (SUPERSOT™-6) CASE 419BL

## **MARKING DIAGRAM**



862 = Specific Device Code M = Date Code

#### **PIN ASSIGNMENT**



#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>	
FDC8602	TSOT23 6-Lead (Pb-Free)	3000 / Tape & Reel	

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

## THERMAL CHARACTERISTICS

Symbol	mbol Parameter		Unit
$R_{ heta JC}$	R <sub>θJC</sub> Thermal Resistance, Junction to Case		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	130	

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
OFF CHARA	ACTERISTICS					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	100	-	_	V
$\Delta BV_{DSS} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25°C	-	73	=	mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 80 V, V <sub>GS</sub> = 0 V	-	-	1	μΑ
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V	-	-	±100	nA
ON CHARAC	CTERISTICS					
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250 μA	2	3.2	4	V
$\Delta V_{GS(th)} / \Delta T_J$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25°C	-	-8	_	mV/°C
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1.2 A	-	285	350	mΩ
		V <sub>GS</sub> = 6 V, I <sub>D</sub> = 0.9 A	-	409	575	
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1.2 A, T <sub>J</sub> = 125°C	-	489	600	
9FS	Forward Transconductance	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1.2 A	-	1.3	_	S
OYNAMIC C	HARACTERISTICS					
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 50 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	53	70	pF
C <sub>oss</sub>	Output Capacitance		-	17	25	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		-	0.8	5	pF
R <sub>g</sub>	Gate Resistance		-	1.6	-	Ω
SWITCHING	CHARACTERISTICS		•		-	-
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 50 \text{ V}, I_D = 1.2 \text{ A}, V_{GS} = 10 \text{ V},$	-	3.5	10	ns
t <sub>r</sub>	Rise Time	$R_{GEN} = 6 \Omega$	-	1.7	10	ns
t <sub>d(off)</sub>	Turn-Off Delay Time		-	5.4	11	ns
t <sub>f</sub>	Fall Time		-	2.3	10	ns
Q <sub>g(TOT)</sub>	Total Gate Charge	V <sub>GS</sub> = 0 V to 10 V, V <sub>DD</sub> = 50 V, I <sub>D</sub> = 1.2 A	_	1.2	2	nC
		$V_{GS} = 0 \text{ V to 5 V, } V_{DD} = 50 \text{ V,}$ $I_D = 1.2 \text{ A}$	-	0.6	1	nC
Q <sub>gs</sub>	Gate to Source Charge	V <sub>DD</sub> = 50 V, I <sub>D</sub> = 1.2 A	-	0.4	-	nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	V <sub>DD</sub> = 50 V, I <sub>D</sub> = 1.2 A	-	0.4	-	nC
DRAIN-SOU	RCE DIODE CHARACTERISTICS	•	-	-	•	-
V <sub>SD</sub>	Source to Drain Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 1.2 A (Note 2)	-	0.86	1.3	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 1.2 A, di/dt = 100 A/μs	-	27	43	ns
		<u></u>				1

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### NOTES:

1.  $R_{\theta JA}$  is the sum of the junction–to–case and case–to–ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a)  $130^{\circ}\text{C/W}$  when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.

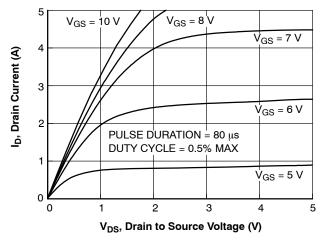


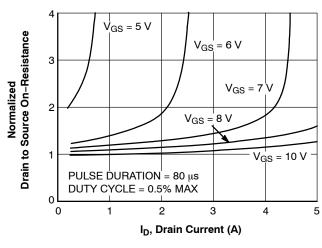
b) 180°C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300  $\mu$ s, Duty cycle < 2.0%. 3. Starting T<sub>J</sub> = 25°C; N-ch: L = 3 mH, I<sub>AS</sub> = 1 A, V<sub>DD</sub> = 100 V, V<sub>GS</sub> = 10 V.

#### **TYPICAL CHARACTERISTICS**

(T<sub>J</sub> = 25°C unless otherwise noted)





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Figure 1. On Region Characteristics

Figure 2. Normalized On–Resistance vs. Drain Current and Gate Voltage

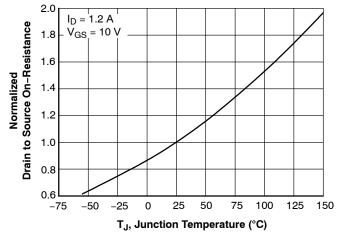


Figure 3. Normalized On Resistance vs. Junction Temperature

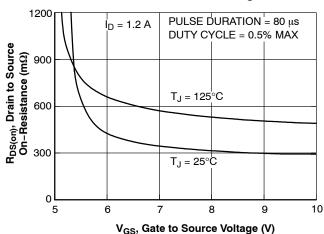


Figure 4. On-Resistance vs. Gate to Source Voltage

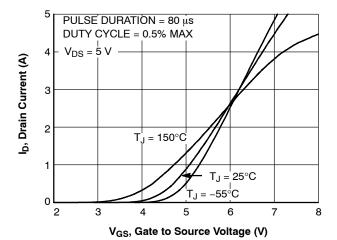


Figure 5. Transfer Characteristics

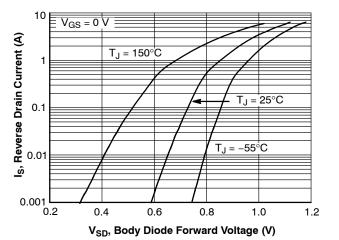


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

## TYPICAL CHARACTERISTICS (continued)

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$ 

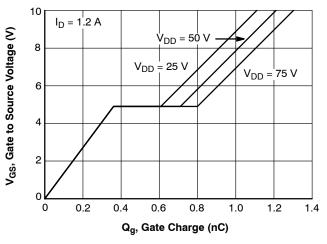


Figure 7. Gate Charge Characteristics

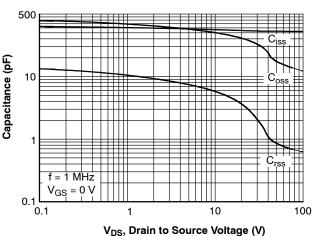


Figure 8. Capacitance vs. Drain to Source

Voltage

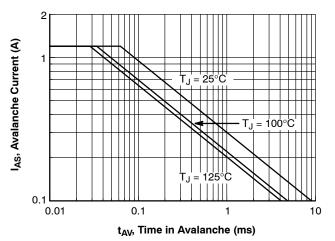


Figure 9. Unclamped Inductive Switching Capability

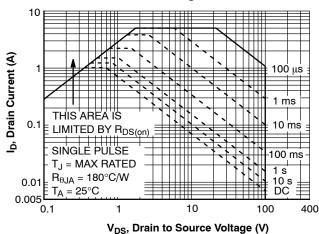


Figure 10. Forward Bias Safe Operating Area

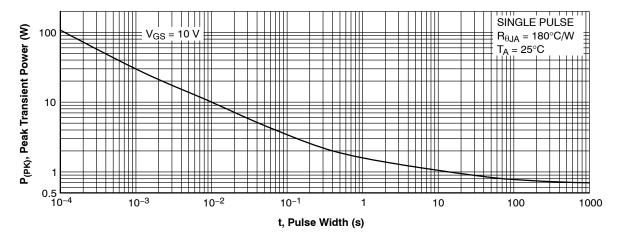


Figure 11. Single Pulse Maximum Power Dissipation

## TYPICAL CHARACTERISTICS (continued)

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$ 

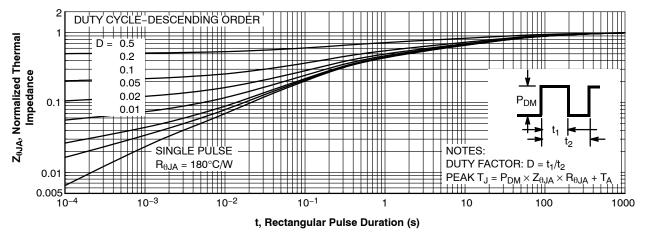


Figure 12. Junction-to-Ambient Transient Thermal Response Curve

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0.20 C

// 0.10 C

0.10 C



PIN 1 **IDENTIFIER** 

#### TSOT23 6-Lead CASE 419BL **ISSUE A**

-[A]

F1

-b

A2

C

GAGE PLANE

SEATING PLANE

A1-

e1 TOP VIEW

FRONT VIEW

**DETAIL A** 

В

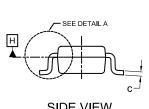
0.20 C

**DATE 31 AUG 2020** 

#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- CONTROLLING DIMENSION: MILLIMETERS
  DIMENSIONS D AND E1 DO NOT INCLUDE MOLD FLASH,
  PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.25MM PER END. DIMENSIONS D AND E1 ARE DETERMINED AT DATUM H.
- 4. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

DIM L

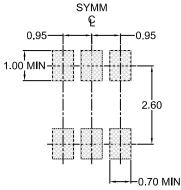


DIM	MIN.	NOM.	MAX.	
Α	0.90	1.00	1.10	
A1	0.00	0.05	0.10	
A2	0.70	0.85	1.00	
А3	0.25 BSC			
b	0.25	0.38	0.50	
С	0.10	0.18	0.26	
D	2.80	2.95	3.10	
d	0.30 REF			
E	2.50	2.75	3.00	
E1	1.30	1.50	1.70	
е	0.95 BSC			
e1	1.90 BSC			
L1	0.60 REF			
L2	0.20	0.40	0.60	
θ	0°		10°	

MILLIMETERS



SIDE VIEW



## LAND PATTERN RECOMMENDATION

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.





XXX = Specific Device Code

= Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ", may or may not be present. Some products may not follow the Generic Marking.

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